

<b>Notice of References Cited</b>	Application/Control No. 10/620,419		Applicant(s)/Patent Under Reexamination FURUKAWA ET AL.	
	Examiner Tuan N. Nguyen		Art Unit 2828	Page 1 of 1

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*	C	US-3,735,280	05-1973	Johnston, Jr., Wilbur Dexter	372/53
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	M	US-			

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**NON-PATENT DOCUMENTS**

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